



On page 7, lines 12-17:

As shown in FIG. 3, the testing module 10 connects both parallel port 21 and serial port 22 of the computer 20. The logic control unit 11 provides four pairs of 8-bit input/output ports for transmitting and receiving control or data signals. In other words, there are 4*8=32 input/output lines for controlling and reading signals of all pins of the parallel port 21 and the serial port 22 and detecting the open or short circuit condition. The detailed connection of the pins and ports are shown in FIG. 6.

Claim 1:

- 1. A universal testing module, capable of connecting to a computer having communication 1 ports to be tested and forming communication paths through said ports, for testing the 2
- condition of each pin of a parallel port and a serial port of said communication ports, at least 3
- comprising: 4
- a logic control unit, having at least a pair of input/output ports for communicating with said 5 6 parallel port:
- a memory unit for storing instructions for controlling said logic control unit and said 7
- computer and for temporary exchange of data; and an universal asynchronous 8
- 9 receiver/transmitter; and
- a voltage converter for voltage interchange of RS-232 and TTL and enabling said logic 10
- control unit to communicate with said computer through said serial port and executing said 11
- 12 testing.

Claim 2:

- 1 2. A universal testing module according to claim 1 wherein said memory unit comprises:
- an electrically erasable programmable read-only memory for storing machine code
- 3 instructions for testing said communication port; and
- a random-access memory for temporary exchange of data.

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Claim 3:

- 1 3. A universal testing module according to claim 1 wherein said memory unit is located outside
- 2 said logic control unit.

Claim 4:

- 1 4. A universal testing module according to claim 1 further comprising a clock circuit for
- 2 providing time signals, and a reset circuit.

Claim 17:

- 1 17. A An universal testing module according to claim 1 wherein said logic control unit further
- 2 comprises:
- a first gate having a first data end, a first output end and a first control end;
- a second gate having a second data end, a second output end and a second control end;
- a flip-flop connecting to either said second control end or said first control end;

- a first pin connecting to said first data end;
- a second pin connecting to said first control end and said flip-flop;
- a third pin connecting to said second data end;
- a fourth pin connecting to said first output end and said second output end.

Claim 18:

- 1 18. A universal testing module according to claim 17 wherein said flip-flop is connected to said
- 2 first control end.

Claim 19:

- 1 19. A universal testing module according to claim 17 wherein said first, second and third pin are
- selectively connected with a pull up resistor for stabilizing voltage when any of said pins is
- 3 open.

Claim 20:

- 1 20. A universal testing module according to claim 17 wherein said first, second and third pin are
- 2 selectively connected with a pull down resistor for stabilizing voltage when any of said pins
- is open.